## **U.S. Patent Documents**

Exam. Init.	Ref. Des.	Document Number	Date	Name	Class	Sub Class	Filing Date of App.
CMIE	A3	5,969,422	10/19/99	Ting et al.	257	762	
CYME	A4	6,461,675 B2	10/08/02	Paranjpe et al.	427	250	
	A5						
	A6						
	A7						

## **Foreign Patent Documents**

Exam. Init.	Ref. Des.	Document Number	Date	Country	Class	Sub Class	Translation Yes/No
	B1						
	B2						
	В3						_

## Other Art (Including Author, Title, Date Pertinent Pages, Etc.)

Exam. Init.	Ref.— Des.	Citation
	C1	
	C2	
	C3	

Examiner:	I Luckast	DATE CONSIDERED:	2-4-05
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